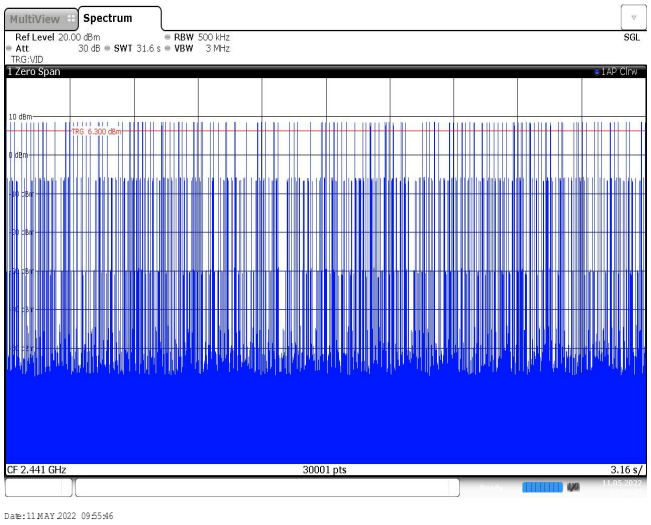
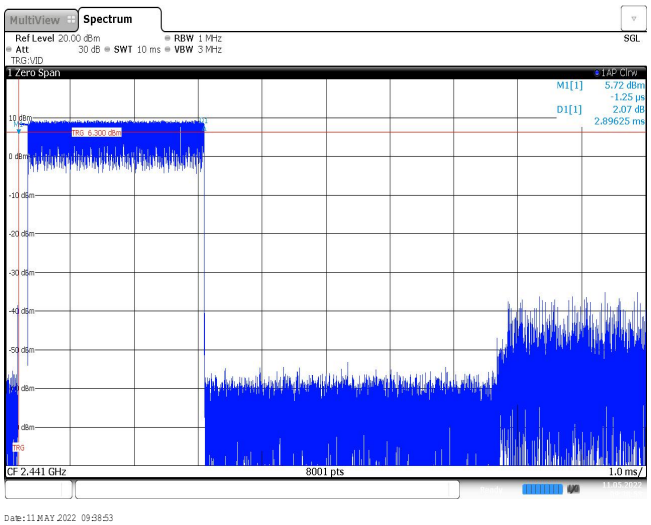
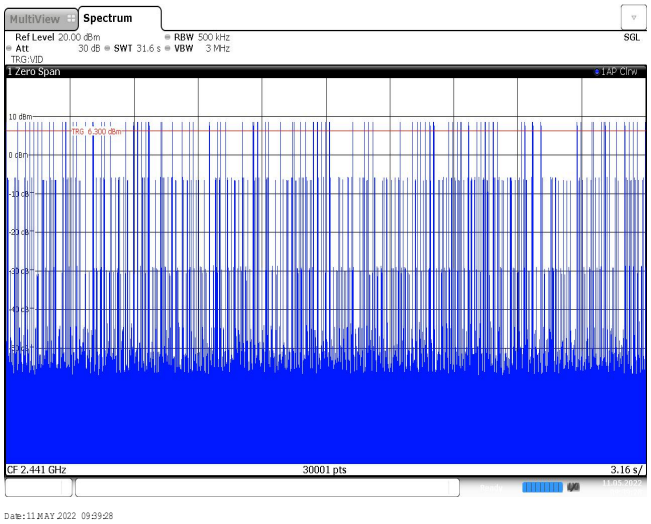
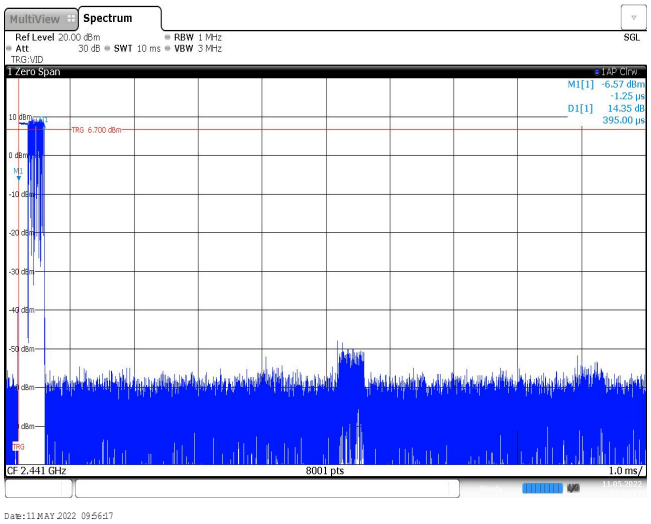
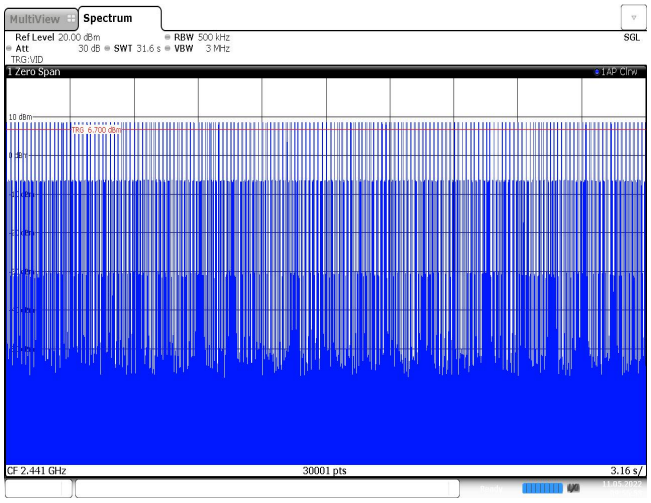
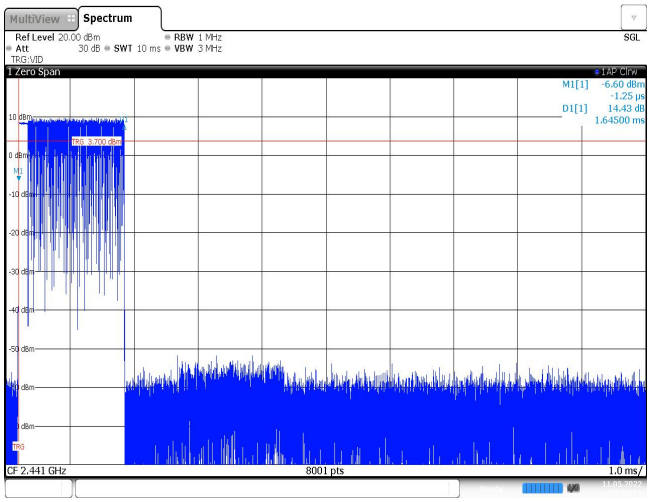
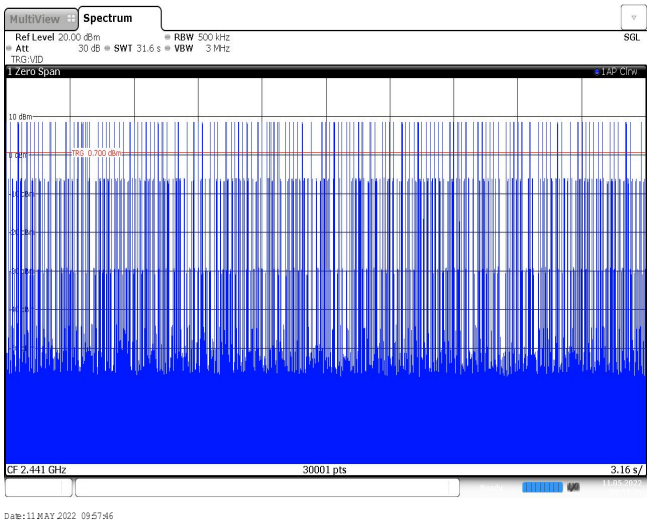
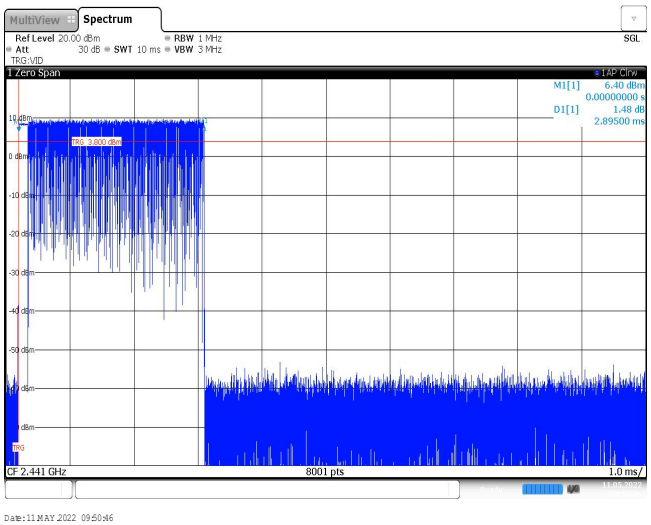
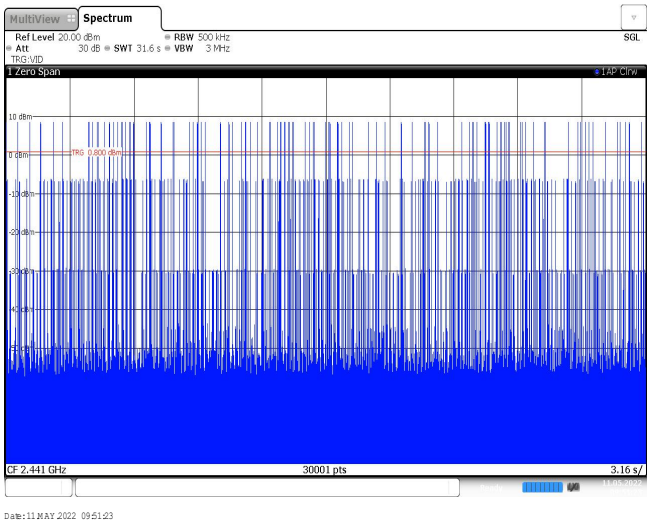
2DH3 Burst number	
2DH5 Burst width	
2DH5 Burst number	

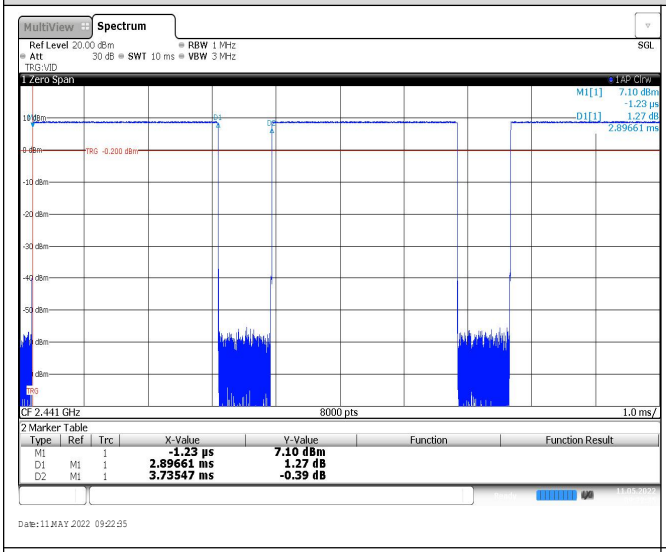
Modulation Type:	8DPSK
3DH1 Burst width	
3DH1 Burst number	
3DH3 Burst width	

3DH3 Burst number	
3DH5 Burst width	
3DH5 Burst number	

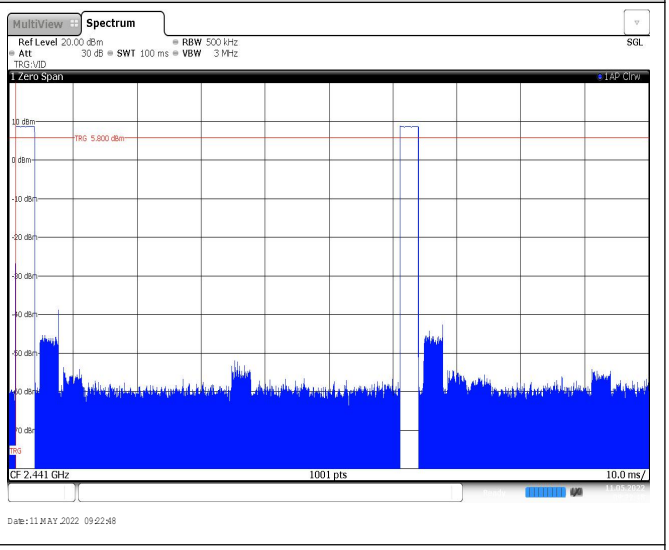
Appendix G：Duty Cycle Correction Factor (DCCF)

DCCF Calculate Formula					
DCCF=20 * Log(duty cycle) = 20 * Log($T_{on\ time}$ / T_{period})					
Modulation type	Test Frequency（MHz）	$T_{on\ time}$ for single burst [ms]	T_{period} [ms]	Burst Quantity	DCCF [dB]
GFSK	2441	2.90	100	2	-24.73
π/4 DQPSK	2441	2.89	100	1	-30.78
8DPSK	2441	2.89	100	1	-30.78

GFSK

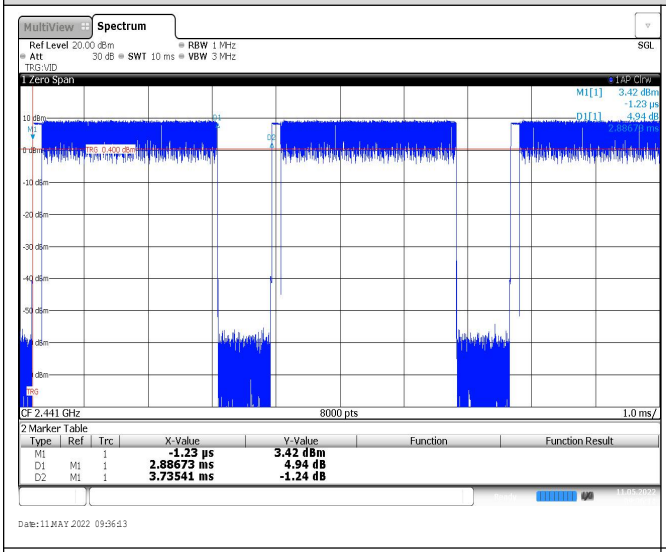


$T_{on\ time}$ for single burst

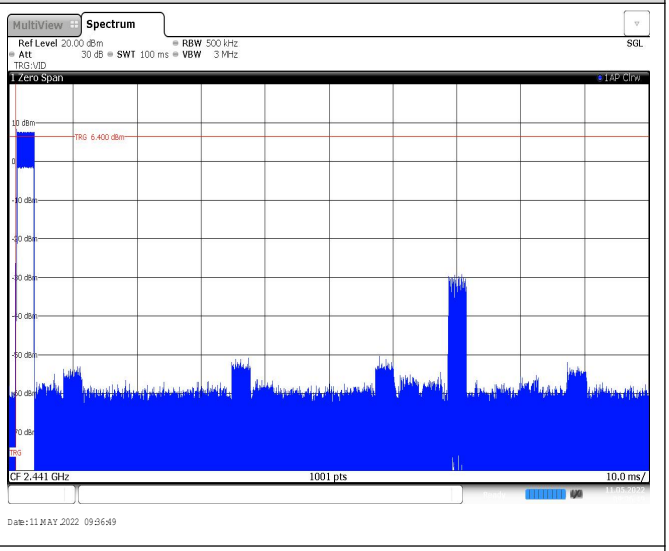


Burst Quantity

π /4 DQPSK

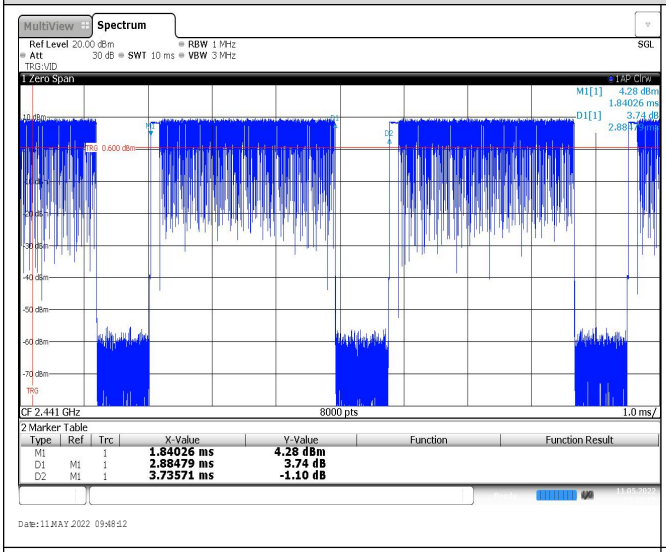


$T_{on\ time}$ for single burst

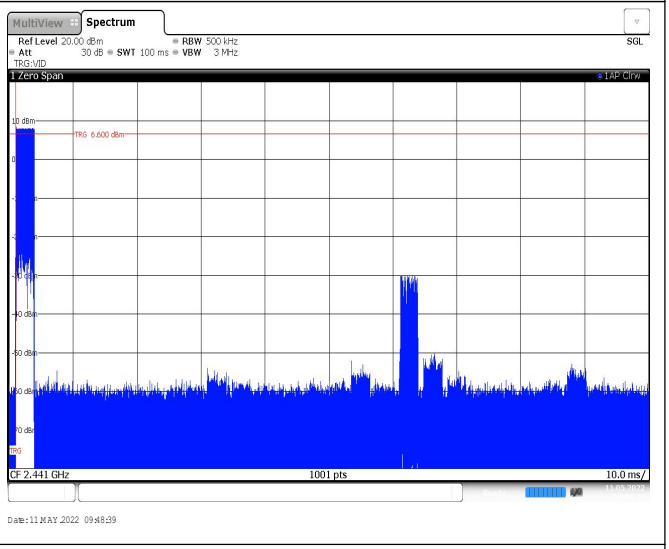


Burst Quantity

8DPSK

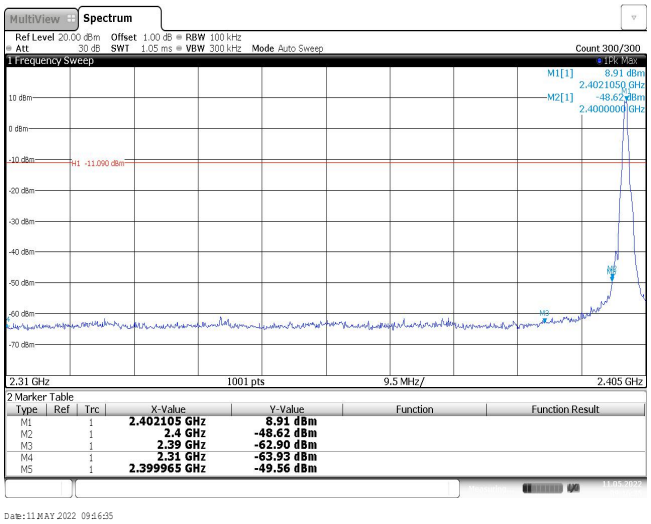
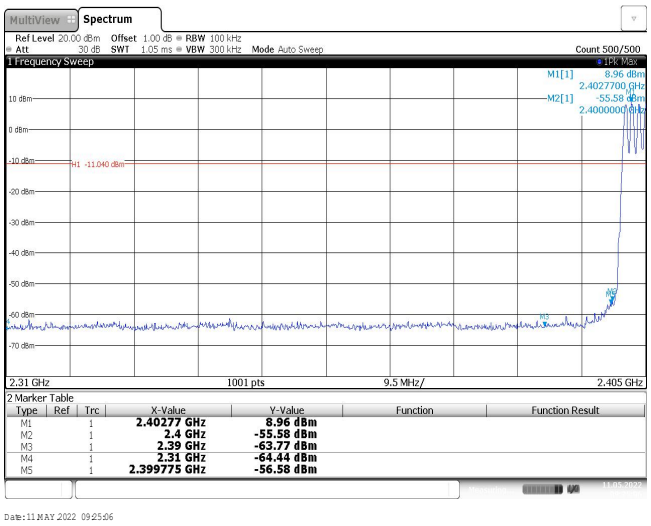
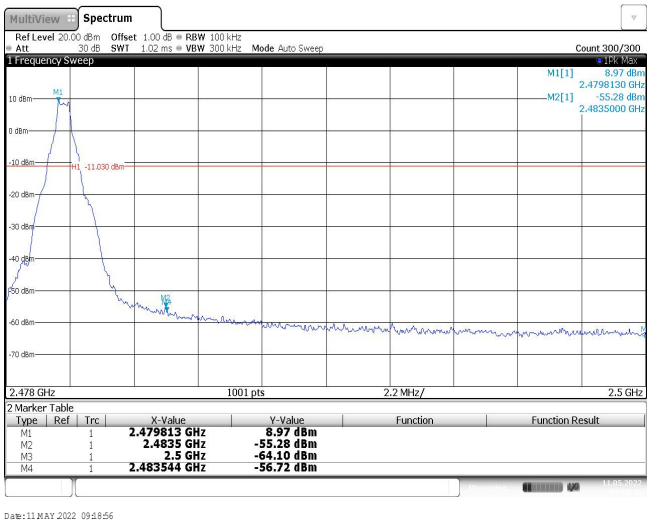


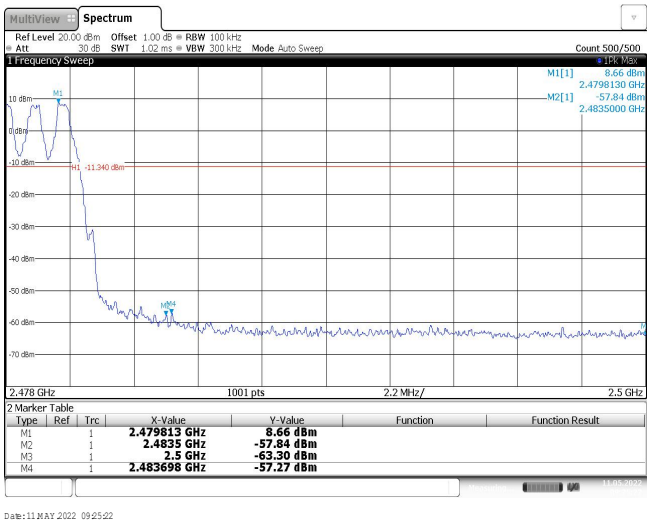
$T_{on\ time}$ for single burst

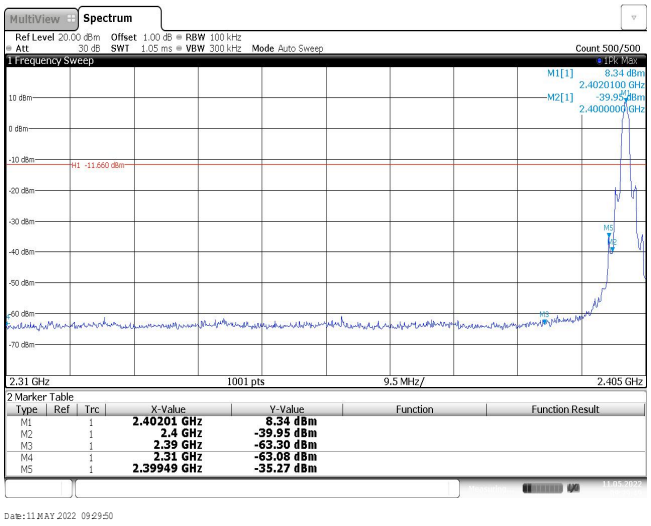
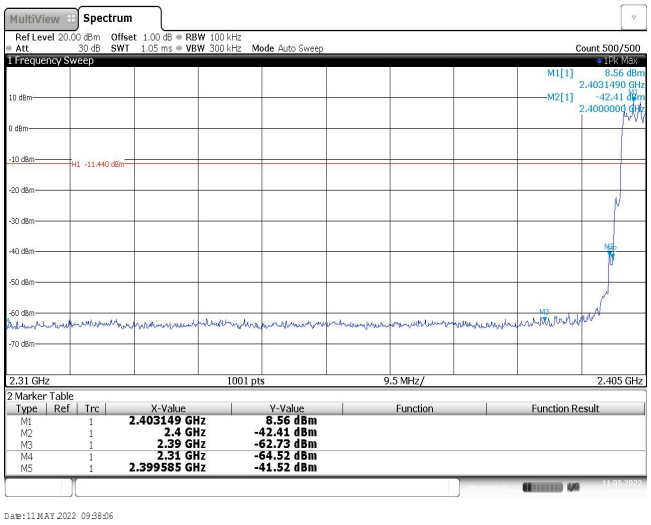
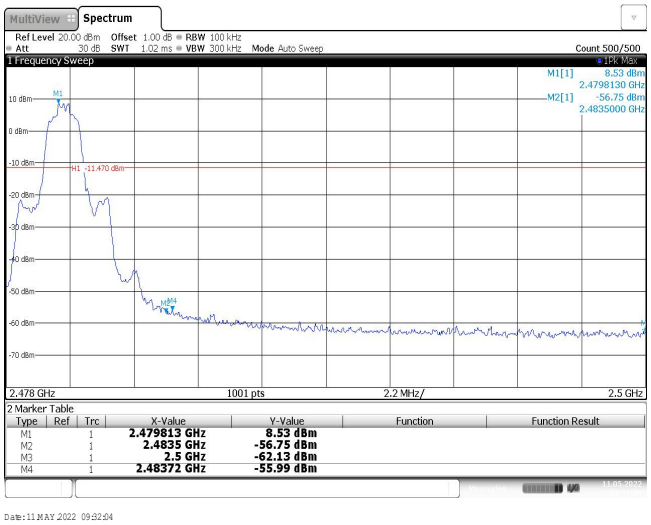


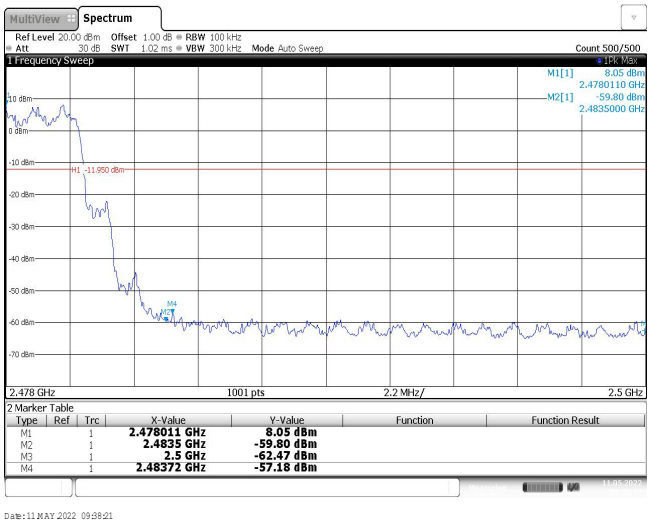
Burst Quantity

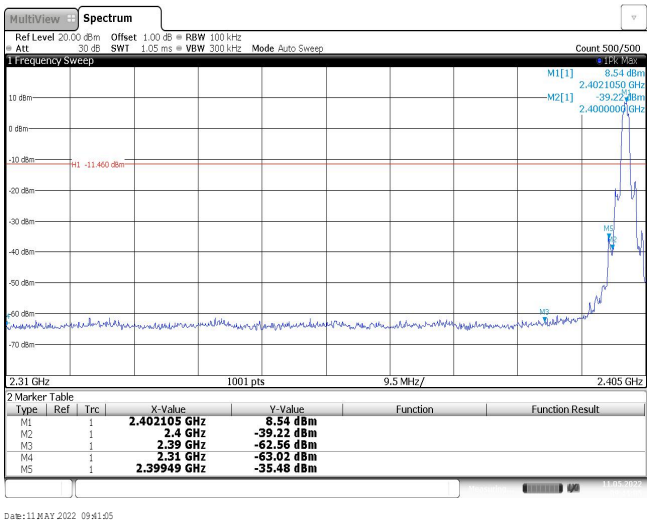
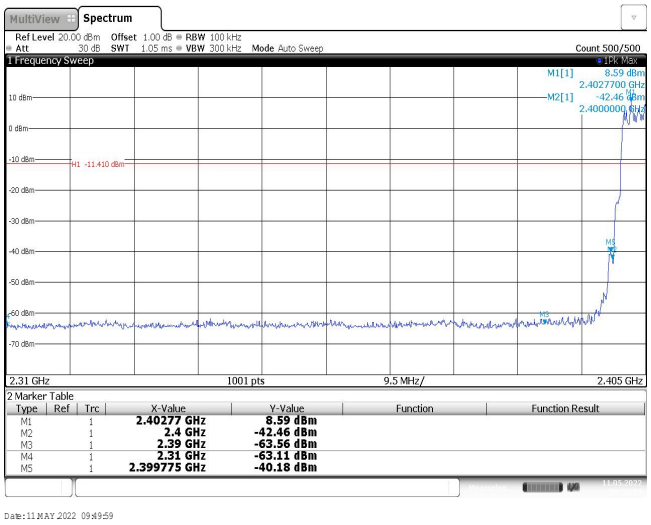
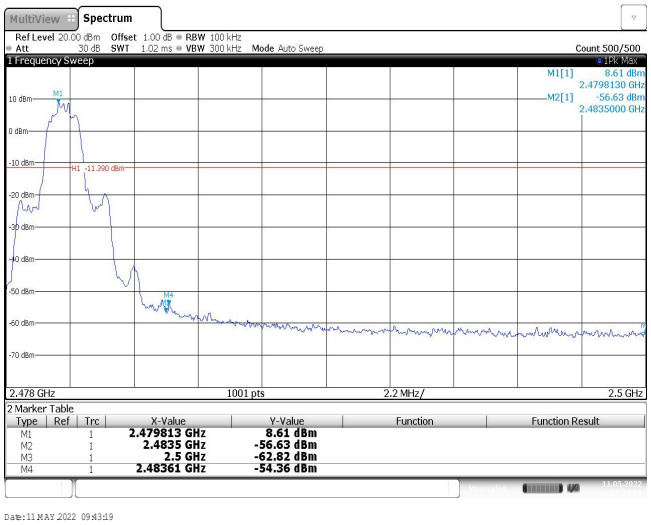
Appendix H：Band edge and Spurious Emissions (conducted)

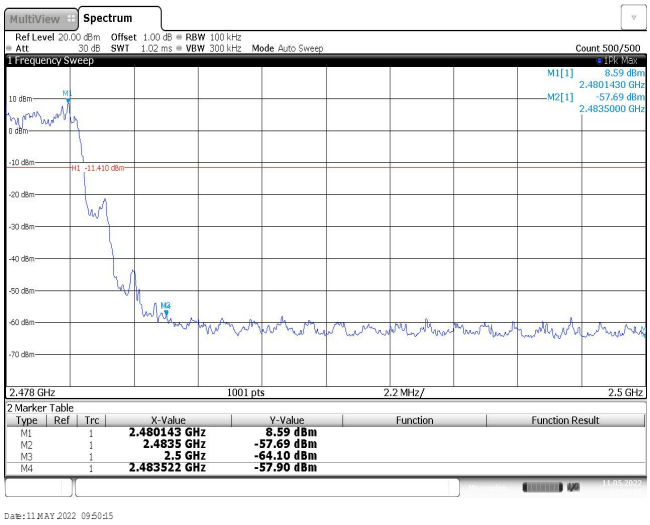
Test Item:	Band edge	Modulation type:	GFSK
CH00 No hopping mode			
CH00 Hopping mode			
CH78 No hopping mode			

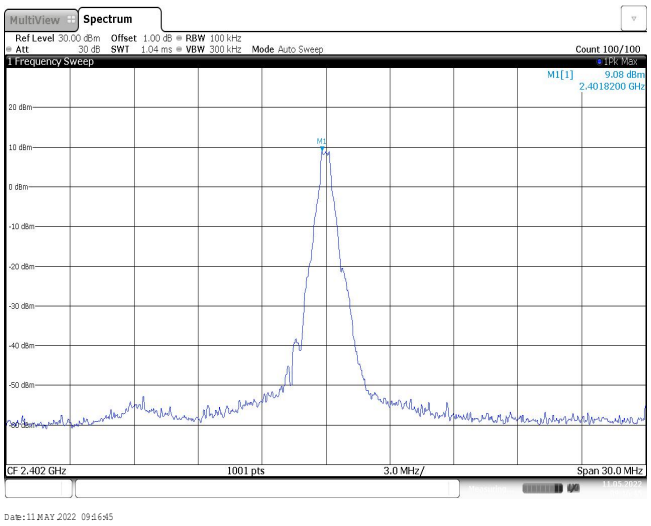
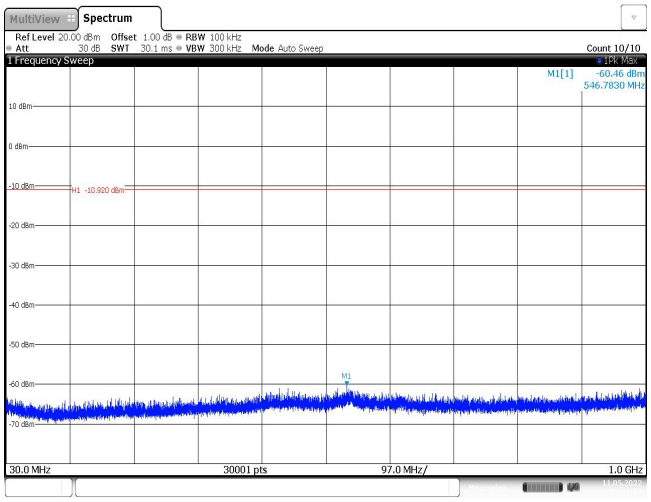
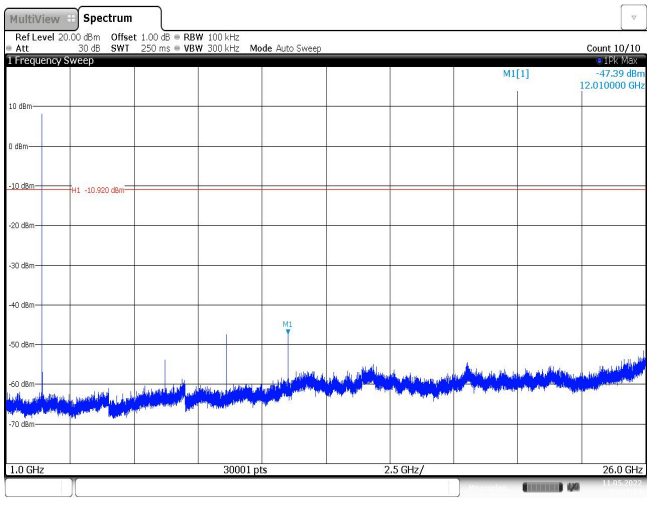
CH78 Hopping mode	

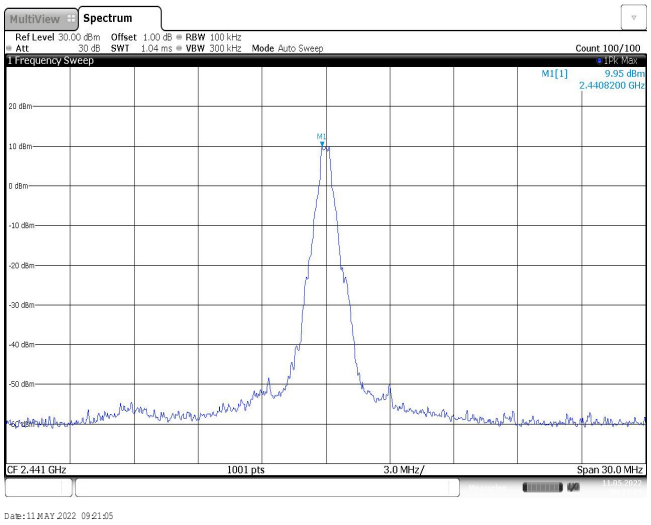
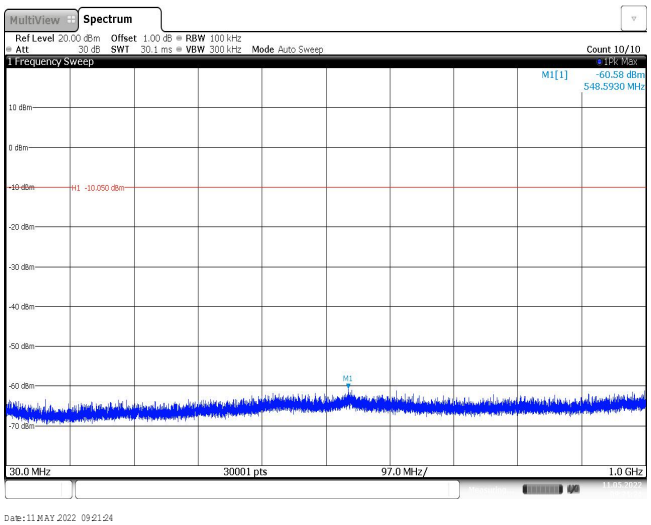
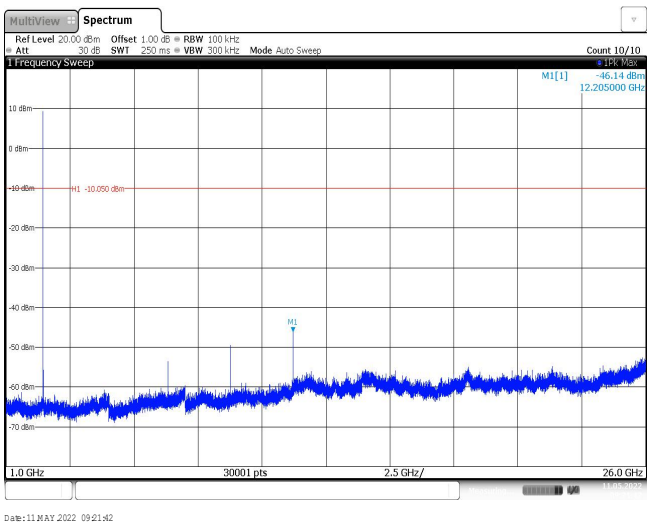
Test Item:	Band edge	Modulation type:	π/4DQPSK
CH00 No hopping mode			
CH00 Hopping mode			
CH78 No hopping mode			

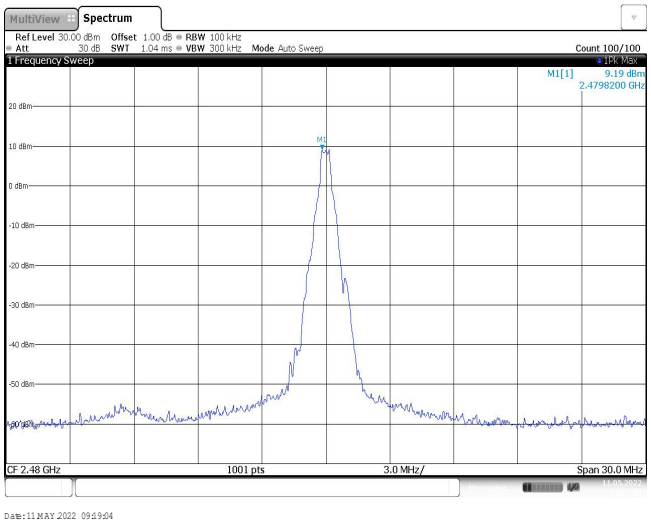
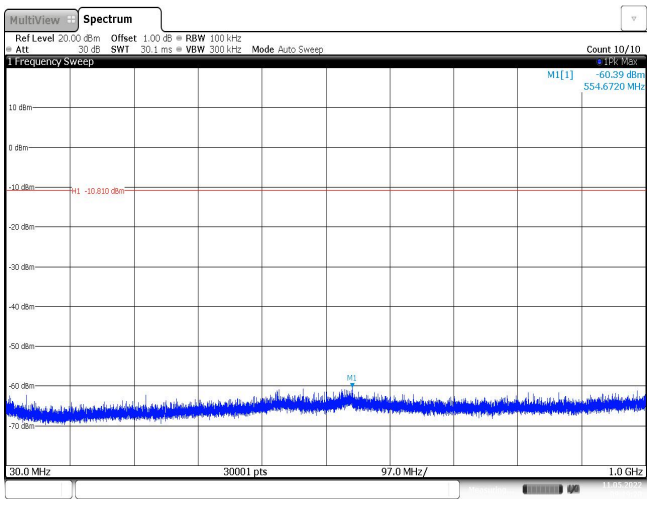
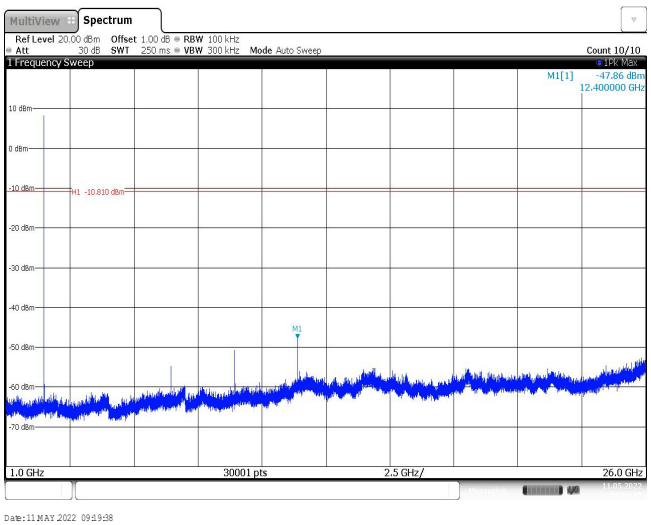
CH78 Hopping mode	

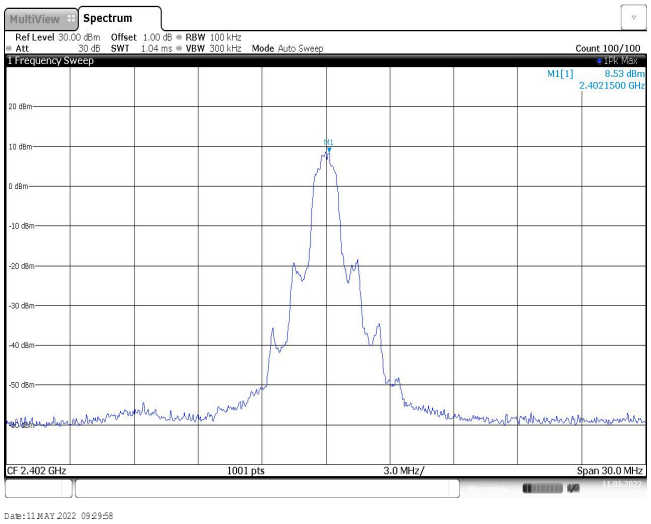
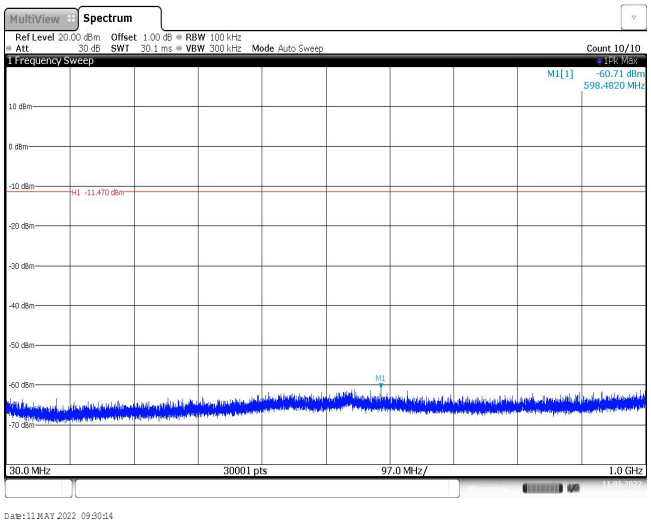
Test Item:	Band edge	Modulation type:	8DPSK
CH00 No hopping mode			
CH00 Hopping mode			
CH78 No hopping mode			

CH78 Hoppig mode	

Test Item:	Spurious Emission	Modulation type:	GFSK
CH00 Reference level			
CH00 30MHz~1000MHz			
CH00 1GHz~26GHz			

CH39 Reference level	
CH39 30MHz~1000MHz	
CH39 1GHz~26GHz	

CH78 Reference level	
CH78 30MHz~1000MHz	
CH78 1GHz~26GHz	

Test Item:	Spurious Emission	Modulation type:	π/4DQPSK
CH00 Reference level			
CH00 30MHz~1000MHz			
CH00 1GHz~26GHz